

**Search Notes**

Application/Control No.

10/502,490

Examiner

TUYEN T. NGUYEN

Applicant(s)/Patent under  
Reexamination

CHOI ET AL.

Art Unit

2832

**SEARCHED**

Class	Subclass	Date	Examiner
336	83, 200, 206-208, 233, 234	5/12/2005	TTN
428	692	5/12/2005	TTN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR